

# **EMC OPTIMIZED CAN TRANSCEIVER**

Check for Samples: SN65HVD1050

#### **FEATURES**

- Improved Replacement for the TJA1050
- High Electromagnetic Immunity (EMI)
- Very Low Electromagnetic Emissions (EME)
- Meets or Exceeds the Requirements of ISO 11898-2
- Bus-Fault Protection of –27 V to 40 V
- Dominant Time-Out Function
- Power-Up/Down Glitch-Free Bus Inputs and Outputs
  - High Input Impedance with Low V<sub>CC</sub>
  - Monotonic Outputs During Power Cycling

#### **APPLICATIONS**

- Industrial Automation
  - DeviceNet<sup>™</sup> Data Buses (Vendor ID #806)
- SAE J2284 High Speed CAN for Automotive Applications
- SAE J1939 Standard Data Bus Interface
- ISO 11783 Standard Data Bus Interface
- NMEA 2000 Standard Data Bus Interface

#### DESCRIPTION

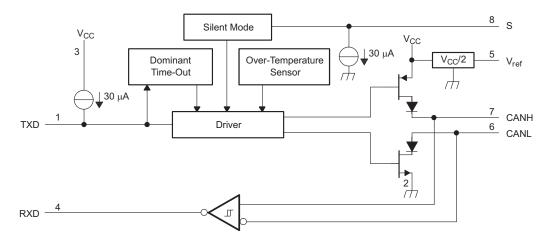
The SN65HVD1050 meets or exceeds the specifications of the ISO 11898 standard for use in applications employing a Controller Area Network (CAN).

As a CAN transceiver, this device provides differential transmit capability to the bus and differential receive capability to a CAN controller at signaling rates up to 1 megabit per second (Mbps)<sup>(1)</sup>.

Designed for operation is especially harsh environments, the HVD1050 features cross-wire, over-voltage and loss of ground protection from -27 V to 40V, over-temperature shut down, a -12 V to 12 V common-mode range, and will withstand voltage transients from -200 V to 200 V according to ISO 7637.

(1) The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).

#### **FUNCTION BLOCK DIAGRAM**



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# **DESCRIPTION (CONTINUED)**

Pin 8 provides for two different modes of operation: high-speed or silent mode. The high-speed mode of operation is selected by connecting S (pin 8) to ground.

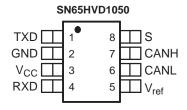
If a high logic level is applied to the S pin of the SN65HVD1050, the device enters a listen-only silent mode during which the driver is switched off while the receiver remains fully functional.

In silent mode, all bus activity is passed by the receiver output to the local protocol controller. When data transmission is required, the local protocol controller reverses this low-current silent mode by placing a logic-low on the S pin to resume full operation.

A dominant-time-out circuit in the SN65HVD1050 prevents the driver from blocking network communication with a hardware or software failure. The time-out circuit is triggered by a falling edge on TXD (pin 1). If no rising edge is seen before the time-out constant of the circuit expires, the driver is disabled. The circuit is then reset by the next rising edge on TXD.

V<sub>ref</sub> (pin 5) is available as a V<sub>CC</sub>/2 voltage reference.

The SN65HVD1050 is characterized for operation from -40°C to 125°C.



#### Table 1. ORDERING INFORMATION

PART NUMBER	PACKAGE	MARKED AS	ORDERING NUMBER
CNICELIVIDADED	2010 0	\/D1050	SN65HVD1050D (rail)
SN65HVD1050	SOIC-8 VP1050 `		SN65HVD1050DR (reel)

#### ABSOLUTE MAXIMUM RATINGS(1)

		UNIT
$V_{CC}$	Supply voltage (2)	−0.3 V to 7 V
	Voltage range at any bus terminal (CANH, CANL, V <sub>ref</sub> )	–27 V to 40 V
Io	Receiver output current	20 mA
$V_{I}$	Voltage input, transient pulse (3) (CANH, CANL)	-200 V to 200 V
$V_{I}$	Voltage input range (TXD, S)	-0.5 V to 6 V
$T_{J}$	Junction temperature	−55°C to 170°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

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<sup>(2)</sup> All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

<sup>(3)</sup> Tested in accordance with ISO 7637, test pulses 1, 2, 3a, 3b, 5, 6, and 7.



# **ELECTROSTATIC DISCHARGE PROTECTION**(1)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	VALUE
IEC Contact Discharge	IEC 61000-4-2	Bus terminals vs GND	±6 kV
Lluman Dady Madal	JEDEC Standard 22,	Bus terminals vs GND	±8 kV
Human Body Model	Test Method A114-C.01	All pins	±4 kV
Field-Induced-Charged Device Model	JEDEC Standard 22, Test Method C101	All pins	±1.5 kV
Machine Model	ANSI/ESDS5.2-1996		±200 V

<sup>(1)</sup> All typical values at 25°C.

## **RECOMMENDED OPERATING CONDITIONS**

		·	MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		4.5		5.5	V
V <sub>I</sub> or V <sub>IC</sub>	Voltage at any bus terminal (separately or common mode)  High-level input voltage  Low-level input voltage  Differential input voltage  High-level output current  Low-level output current  Driver  Receiver  Driver  Receiver  Driver  Receiver  See Thermal Characteristics table, 1 Mbps minimum signaling rate with R <sub>L</sub> = 54Ω	(separately or common mode)	-12		12	V
V <sub>IH</sub>	High-level input voltage	TVD C	2.1	5.5 5.5 2 12 1 V <sub>CC</sub> 0 0.8 7 7 0 2 2 2 0 150	V	
V <sub>IL</sub>	Low-level input voltage	TXD, S	0		0.8	V
V <sub>ID</sub>	Differential input voltage	voltage			7	V
V <sub>ID</sub>	High-level output current	Driver	-70			mA
		Receiver	-2			
	Landard and and	Driver			70	^
I <sub>OL</sub>	Low-level output current	Receiver			V <sub>CC</sub> 0.8 7 70 2	mA
T <sub>J</sub>	Junction temperature	See Thermal Characteristics table, 1 Mbps minimum signaling rate with R $_{L}=54\Omega$	-40		150	°C
	Signaling Rate		20			kbps

## **SUPPLY CURRENT**

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT	
		Silent mode	S at $V_{CC}$ , $V_I = V_{CC}$			6	10	
	,	Dominant V <sub>I</sub> =	V 0V 00 01 1 0 10V	4.75V < V <sub>CC</sub> < 5.25V		50	70	
I <sub>CC</sub>			$V_I = 0 \text{ V}, 60 \Omega \text{ Load}, \text{ S at } 0 \text{ V}$	4.5V < V <sub>CC</sub> < 5.5V			75	mA
		Recessive	V <sub>I</sub> = V <sub>CC</sub> , No Load, S at 0 V			6	10	

## **DEVICE SWITCHING CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST	CONDITIONS	MIN	TYP MAX	UNIT
	Total loop delay, driver input to receiver output,		4.75V < V <sub>CC</sub> < 5.25V	90	190	
<sup>t</sup> d(LOOP1)	recessive to dominant	Figure 9, S at	4.5V < V <sub>CC</sub> < 5.5V	85	195	
	Total loop delay, driver input to receiver output,	0V	4.75V < V <sub>CC</sub> < 5.25V	90	190	ns
<sup>t</sup> d(LOOP2)	dominant to recessive		4.5V < V <sub>CC</sub> < 5.5V	85	195	

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## **DRIVER ELECTRICAL CHARACTERISTICS**

over recommended operating conditiions (unless otherwise noted)

	PARAMETER		TEST CO	NDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
		CANH		4.75V < V <sub>CC</sub> < 5.25V	2.9	3.4	4.5	
\/	Due cutaut voltage (Deminent)	CANH	$V_I = 0 \text{ V}, \text{ S at } 0 \text{ V}, \text{ R}_L$ = 60 $\Omega$ , See Figure 1	4.5V < V <sub>CC</sub> < 5.5V	2.75		5.2	V
$V_{O(D)}$	Bus output voltage (Dominant)	CANII	and Figure 2	4.75V < V <sub>CC</sub> < 5.25V	0.8		1.5	V
		CANL		4.5V < V <sub>CC</sub> < 5.5V			1.6	
			V <sub>I</sub> = 3 V, S at 0 V, R <sub>L</sub>	4.75V < V <sub>CC</sub> < 5.25V	2	2.3	3	
$V_{O(R)}$	Bus output voltage (Recessive)		= $60 \Omega$ , See Figure 1 and Figure 2	4.5V < V <sub>CC</sub> < 5.5V	1.8		3	V
			$V_I = 0 \ V, \ R_L = 60 \ \Omega, \ S$	4.75V < V <sub>CC</sub> < 5.25V	1.5		3	
V	Differential output voltage (Dominant)		at 0 V, See Figure 1, Figure 2, and Figure 3	4.5V < V <sub>CC</sub> < 5.5V	1.4		3	V
$V_{OD(D)}$	Differential output voltage (Doil	iii iai ii)	$V_I = 0 \text{ V}, R_L = 45 \Omega, S$ at 0 V, See Figure 1,	4.75V < V <sub>CC</sub> < 5.25V	1.4		3	
				4.5V < V <sub>CC</sub> < 5.5V	1.3		3	V
V	Differential output valtege (Dec	Differential output voltage (Recessive)		Figure 1 and Figure 2	-0.012		0.012	V
$V_{OD(R)}$	Differential output voltage (Reco			₋oad	-0.5		0.05	V
V	Steady state common-mode ou	tput		4.75V < V <sub>CC</sub> < 5.25V	2	2.3	3	V
V <sub>OC(ss)</sub>	voltage		S at 0 V, Figure 8	4.5V < V <sub>CC</sub> < 5.5V	1.9		3	V
$\Delta V_{OC(ss)}$	Change in steady-state commo output voltage	n-mode	o at o 1, 1 iguilo o			30		mV
I <sub>IH</sub>	High-level input current, TXD in	put	V <sub>I</sub> at V <sub>CC</sub>	1	-2		2	
I <sub>IL</sub>	Low-level input current, TXD inp	out	V <sub>I</sub> at 0 V		-50		-10	μΑ
I <sub>O(off)</sub>	Power-off TXD output current		V <sub>CC</sub> at 0 V, TXD at 5 V				1	
			V <sub>CANH</sub> = -12 V, CANL (	Open, See Figure 11	-105	-72		mA
	Chart sine it stands at the sector		V <sub>CANH</sub> = 12 V, CANL C	pen, SeeFigure 11		0.36	1	
I <sub>OS(ss)</sub>	Short-circuit steady-state outpu	current	V <sub>CANL</sub> = -12 V, CANH (	Open, See Figure 11	-1	-0.5		
				V <sub>CANL</sub> = 12 V, CANH Open, See Figure 11		71	105	1
Co	Output capacitance		See receiver input capa	acitance				

<sup>(1)</sup> All typical values are at 25°C with a 5-V supply.

## **DRIVER SWITCHING CHARACTERISTICS**

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TE	ST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time, low-to-high-level output			25	65	120	
t <sub>PHL</sub>	Propagation delay time, high-to-low-level output	S at 0 V, See Figure 4	Figure 4	25	45	90	
t <sub>r</sub>	Differential output signal rise time	S at 0 V, See Figure 4			25		ns
t <sub>f</sub>	Differential output signal fall time				50		
t <sub>en</sub>	Enable time from silent mode to dominant	See Figure 7				1	μS
	Dominant time-out	↓V <sub>I</sub> , See	4.75V < V <sub>CC</sub> < 5.25V	300	450	-	
t <sub>(dom)</sub>	Dominant time-out	Figure 10	$4.5V < V_{CC} < 5.5V$	280			μS



## RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST (	CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
$V_{IT+}$	Positive-going input threshold voltage	C at 0 V Can Tab	lo 4		800	900	
V <sub>IT</sub> _	Negative-going input threshold voltage	S at 0 V, See Tab	S at 0 V, See Table 4		650		mV
V <sub>hys</sub>	Hysteresis voltage (V <sub>IT+</sub> – V <sub>IT-</sub> )			100	125		
V	Libert Level autout valtage	$I_{O} = -2$ mA, See	4.75V < V <sub>CC</sub> < 5.25V	4	4.6		
V <sub>OH</sub>	High-level output voltage	Figure 6	4.5V < V <sub>CC</sub> < 5.5V	3.8			V
V <sub>OL</sub>	Low-level output voltage	I <sub>O</sub> = 2 mA, See Fi	I <sub>O</sub> = 2 mA, See Figure 6		0.2	0.4	V
I <sub>I(off)</sub>	Power-off bus input current	Other pin at 0 V,	CANH or CANL = 5 V, Other pin at 0 V, V <sub>CC</sub> at 0 V, TXD at 0 V		165	250	μΑ
I <sub>O(off)</sub>	Power-off RXD leakage current	V <sub>CC</sub> at 0 V, RXD a	at 5 V			20	μА
C <sub>I</sub>	Input capacitance to ground, (CANH or CANL)	TXD at 3 V, V <sub>I</sub> = 0.4 sin (4E6π			13		pF
C <sub>ID</sub>	Differential input capacitance	TXD at 3 V, $V_I = 0$	0.4 sin (4E6πt)		5		
R <sub>ID</sub>	Differential input resistance	TVD -+ 2 V C -+ 0	N/	30		80	1.0
R <sub>IN</sub>	Input resistance, (CANH or CANL)	IAD at 3 V, S at 0	TXD at 3 V, S at 0 V		30	40	kΩ
R <sub>I(m)</sub>	Input resistance matching [1 – (R <sub>IN (CANH)</sub> ) / R <sub>IN (CANL)</sub> )] x 100%	$V_{(CANH)} = V_{(CANL)}$		-3%	0%	3%	

<sup>(1)</sup> All typical values are at 25°C with a 5-V supply.

#### RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time, low-to-high-level output		4.75V < V <sub>CC</sub> < 5.25V	60	100	130	
			4.5V < V <sub>CC</sub> < 5.5V	60		135	
t <sub>PHL</sub>	Propagation delay time, high-to-low-level output	S at 0 V or V <sub>CC</sub> , See	4.75V < V <sub>CC</sub> < 5.25V	45	70	90	
		Figure 6	$4.5V < V_{CC} < 5.5V$	45		95	ns
t <sub>r</sub>	Output signal rise time				8		
t <sub>f</sub>	Output signal fall time				8		

## S-PIN CHARACTERISTICS

over recommended operating conditiions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{IH}$	High level input current	S at 2 V	20	40	70	^
$I_{\rm IL}$	Low level input current	S at 0.8 V	5	20	30	μΑ

#### **VREF-PIN CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Vo	Reference output voltage	–50 μA < I <sub>O</sub> < 50 μA	0.4 V <sub>CC</sub>	0.5 V <sub>CC</sub>	0.6 V <sub>CC</sub>	V

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#### THERMAL CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
0	Junction-to-Air	Low-K thermal resistance <sup>(1)</sup>	211		
$\theta_{JA}$	Junction-to-All	High-K thermal resistance	131		
$\theta_{JB}$	Junction-to-Board Thermal Resistance		53		°C/W
$\theta_{JC}$	Junction-to-Case Thermal Resistance		79		
D	Average neway discipation	$V_{CC}$ = 5.0 V, $T_j$ = 27°C, $R_L$ = 60 $\Omega$ , S at 0 V, Input to TXD a 500 kHz, 50% duty cycle square wave. CL at RXD = 15 pF	112		mW
$P_D$	Average power dissipation	$V_{CC}$ = 5.5 V, $T_{j}$ = 130°C, $R_{L}$ = 45 $\Omega,$ S at 0 V, Input to TXD a 500 kHz, 50% duty cycle square wave. CL at RXD = 15 pF		170	
T <sub>J_shutdown</sub>	Junction temperature, thermal shutdown <sup>(2)</sup>		190		°C

- Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface-mount packages. Extended operation in thermal shutdown may affect device reliability, see APPLICATIONS INFORMATION.

## **FUNCTION TABLES**

Table 2. DRIVER

INP	UTS	OUTI	BUS STATE	
TXD <sup>(1)</sup>	S <sup>(1)</sup>	CANH <sup>(1)</sup>	CANL <sup>(1)</sup>	
L	L or Open	Н	L	DOMINANT
Н	X	Z	Z	RECESSIVE
Open	X	Z	Z	RECESSIVE
X	Н	Z	Z	RECESSIVE

(1) H = high level; L = low level; X = irrelevant; ? = indeterminate; Z = high impedance

**Table 3. RECEIVER** 

DIFFERENTIAL INPUTS V <sub>ID</sub> = V(CANH) - V(CANL)	OUTPUT RXD <sup>(1)</sup>	BUS STATE
V <sub>ID</sub> ≥ 0.9 V	L	DOMINANT
$0.5 \text{ V} < \text{V}_{\text{ID}} < 0.9 \text{ V}$	?	?
V <sub>ID</sub> ≤ 0.5 V	Н	RECESSIVE
Open	Н	RECESSIVE

(1) H = high level; L = low level; X = irrelevant; ? = indeterminate; Z = high impedance

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#### PARAMETER MEASUREMENT INFORMATION

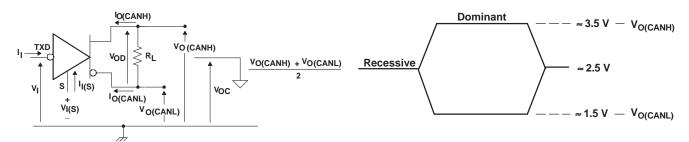


Figure 1. Driver Voltage, Current, and Test Definition

Figure 2. Bus Logic State Voltage Definitions

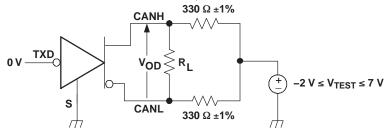


Figure 3. Driver V<sub>OD</sub> Test Circuit

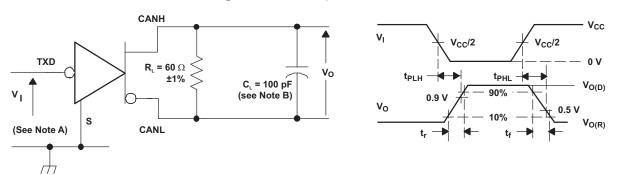


Figure 4. Driver Test Circuit and Voltage Waveforms

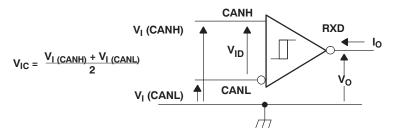
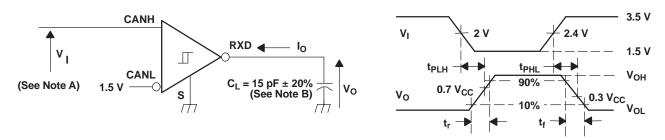


Figure 5. Receiver Voltage and Current Definitions



## PARAMETER MEASUREMENT INFORMATION (continued)

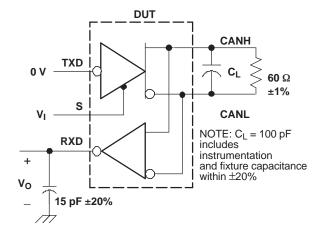


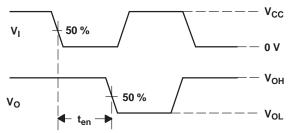
- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  125 kHz, 50% duty cycle,  $t_r \leq$  6 ns,  $t_f \leq$  6ns,  $Z_O =$  50  $\Omega$ .
- B. C<sub>L</sub> includes instrumentation and fixture capacitance within ±20%.

Figure 6. Receiver Test Circuit and Voltage Waveforms

Table 4. Differential Input Voltage Threshold Test

	INPUT		OUTPUT			
V <sub>CANH</sub>	V <sub>CANL</sub>	V <sub>ID</sub>		R		
–11.1 V	–12 V	900 mV	L	V <sub>OL</sub>		
12 V	11.1 V	900 mV	L			
-6 V	-12 V	6 V	L			
12 V	6 V	6 V	L			
–11.5 V	-12 V	500 mV	Н	V <sub>OH</sub>		
12 V	11.5 V	500 mV	Н			
-12 V	-6 V	6 V	Н			
6 V	12 V	6 V	Н			
Open	Open	X	Н			

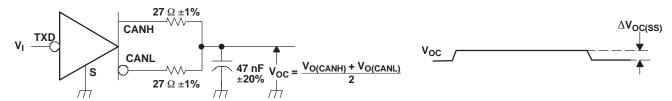




NOTE: All V<sub>I</sub> input pulses are supplied by a generator having the following characteristics:  $t_r$  or  $t_f \le 6$  ns, Pulse Repetition Rate (PRR) = 25 kHz, 50% duty cycle

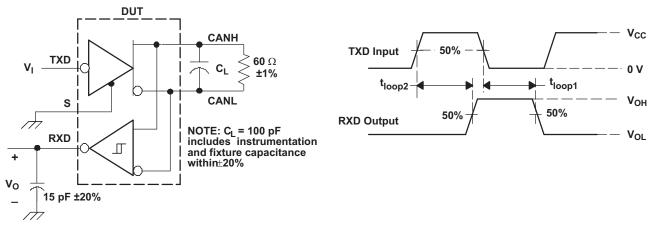
Figure 7. t<sub>en</sub> Test Circuit and Waveform





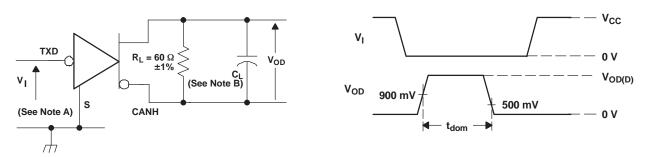
NOTE: All  $V_1$  input pulses are from 0 V to  $V_{CC}$  and supplied by a generator having the following characteristics:  $t_f$  or  $t_f \le 6$  ns. Pulse Repetition Rate (PRR) = 125 kHz, 50% duty cycle.

Figure 8. Common Mode Output Voltage Test and Waveforms



All  $V_I$  input pulses are from 0 V to  $V_{CC}$  and supplied by a generator having the following characteristics:  $t_f$  or  $t_f \le 6$  ns. Pulse Repetition Rate (PRR) = 125 kHz, 50% duty cycle.

Figure 9.  $t_{(LOOP)}$  Test Circuit and Waveform



- All  $V_I$  input pulses are from 0 V to  $V_{CC}$  and supplied by a generator having the following characteristics:  $t_r$  or  $t_f \le 6$  ns. Pulse Repetition Rate (PRR) = 500 Hz, 50% duty cycle.
- C<sub>L</sub> = 100 pF includes instrumentation and fixture capacitance within ±20%.

Figure 10. Dominant Time-Out Test Circuit and Waveforms



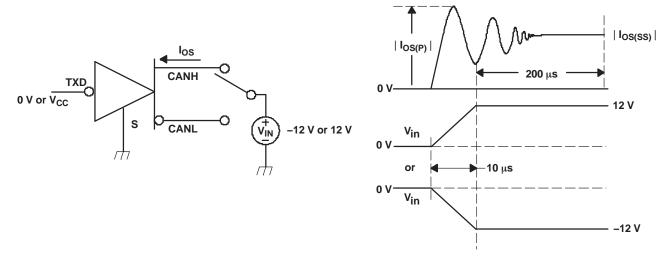


Figure 11. Driver Short-Circuit Current Test and Waveform



## **DEVICE INFORMATION**

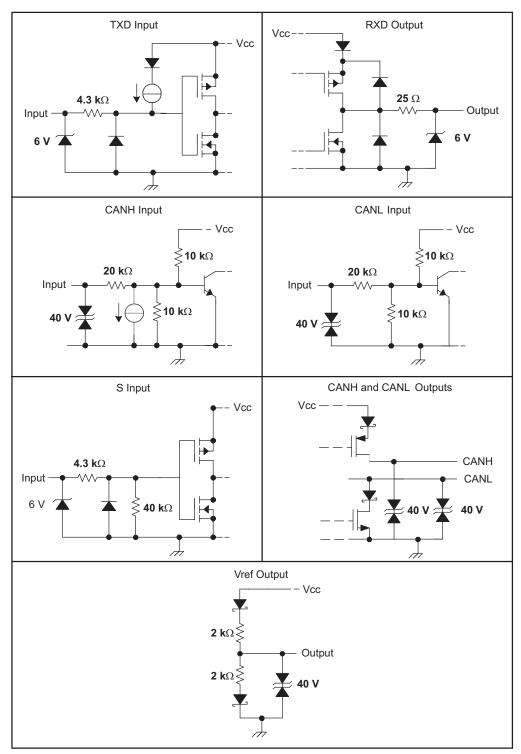
Table 5. Parametric Cross Reference With the TJA1050

$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	
$\begin{array}{cccc} I_{O(SC)} & Short-circuit output current & Driver  I_{OS(SS)} \\ V_{O(dom)} & Dominant output voltage & Driver  V_{O(D)} \\ V_{i(dif)(th)} & Differential input voltage & Receiver  V_{IT}  and  recommended  T_{O(SC)} \\ \end{array}$	
$\begin{array}{ccc} V_{O(dom)} & \text{Dominant output voltage} & \text{Driver V}_{O(D)} \\ V_{i(dif)(th)} & \text{Differential input voltage} & \text{Receiver V}_{IT} \text{ and recommended} \end{array}$	
$V_{i(dif)(th)}$ Differential input voltage Receiver $V_{IT}$ and recommended	J
\(\frac{1}{2}\)	
M. Differential insert heart areais.	$V_{ID}$
$V_{i(dif)(hys)}$ Diffrential input hysteresis Receiver $V_{hys}$	
$V_{O(reces)}$ Recessive output voltage Driver $V_{O(R)}$	
$V_{O(dif)(bus)}$ Differential bus voltage Driver $V_{OD(D)}$ and $V_{OD(R)}$	
$R_{i(cm)}$ CANH, CANL input resistance Receiver $R_{IN}$	
$R_{i(dif)}$ Differential input resistance Receiver $R_{ID}$	
$R_{i(cm)\ (m)}$ Input resistance matching Receiver $R_{i\ (m)}$	
C <sub>i</sub> Input capacitance to ground Receiver C <sub>I</sub>	
$C_{i(dif)}$ Differential input capacitance Receiver $C_{ID}$	
RECEIVER SECTION	
I <sub>OH</sub> High-level output current Recommended I <sub>OH</sub>	
I <sub>OL</sub> Low-level output current Recommended I <sub>OL</sub>	
Vref PIN SECTION	
V <sub>ref</sub> Reference output voltage V <sub>O</sub>	
TIMING SECTION	
t <sub>d(TXD-BUSon)</sub> Delay TXD to bus active Driver t <sub>PLH</sub>	
$t_{d(TXD\text{-BUSoff})}$ Delay TXD to bus inactive Driver $t_{PHL}$	
t <sub>d(BUSon-RXD)</sub> Delay bus active to RXD Receiver t <sub>PHL</sub>	
$t_{d(BUSoff\text{-RXD})}$ Delay bus inactive to RXD Receiver $t_{PLH}$	
$t_{d(TXD-BUSon)} + t_{d(BUSon-RXD)}$ Device $t_{LOOP1}$	
$t_{d(TXD-BUSoff)} + t_{d(BUSoff-RXD)}$ Device $t_{LOOP2}$	
$t_{dom(TXD)}$ Dominant time out Driver $t_{(dom)}$	
S PIN SECTION	
$V_{IH}$ High-level input voltage Recommended $V_{IH}$	
$V_{IL}$ Low-level input voltage Recommended $V_{IL}$	
I <sub>IH</sub> High-level input current I <sub>IH</sub>	
I <sub>IL</sub> Low-level input current I <sub>IL</sub>	

<sup>(1)</sup> From TJA1050 Product Specification, Philips Semiconductors, 2002 May 16.



# **Equivalent Input and Output Schematic Diagrams**





#### TYPICAL CHARACTERISTICS

#### RECESSIVE-TO-DOMINANT LOOP TIME



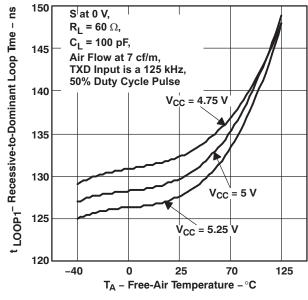


Figure 12.

# SUPPLY CURRENT (RMS) vs SIGNALING RATE

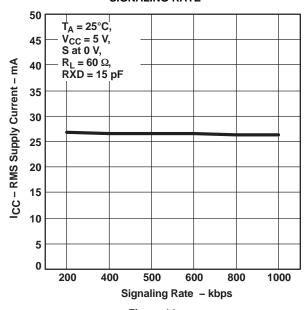


Figure 14.

# DOMINANT-TO-RECESSIVE LOOP TIME vs FREE-AIR TEMPERATURE (across V<sub>CC</sub>)

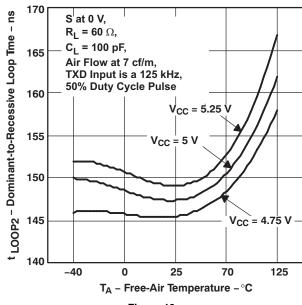


Figure 13.

# DRIVER LOW-LEVEL OUTPUT VOLTAGE vs LOW-LEVEL OUTPUT CURRENT

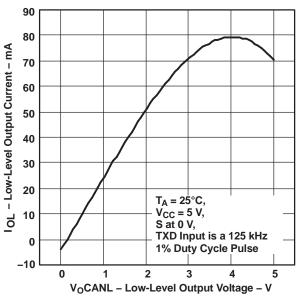


Figure 15.



## **TYPICAL CHARACTERISTICS (continued)**

#### **DRIVER HIGH-LEVEL OUTPUT VOLTAGE** VS HIGH-LEVEL OUTPUT CURRENT -80 $T_A = 25 C$ V<sub>CC</sub> = 5 V, S at 0 V, IOH - High-Level Output Current - mA -70 TXD Input is a 125 kHz 1% Duty Cycle Pulse -60 -50 -40 -30 -20 -10 -0 0 2 3 4 5

Figure 16.

VoCANH - High-Level Output Voltage - V

#### DRIVER OUTPUT CURRENT vs SUPPLY VOLTAGE

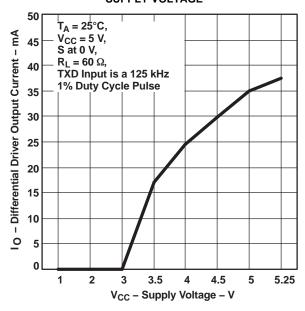
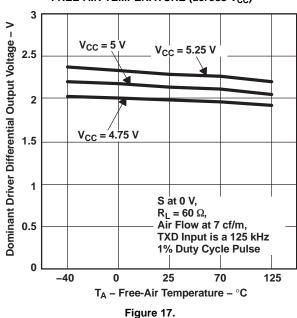


Figure 18.

# DRIVER DIFFERENTIAL OUTPUT VOLTAGE vs FREE-AIR TEMPERATURE (across V<sub>CC</sub>)



RECEIVER OUTPUT VOLTAGE

#### vs DIFFERENTIAL INPUT VOLTAGE

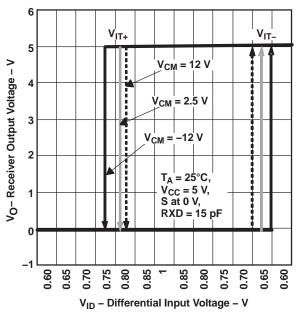


Figure 19.



# **TYPICAL CHARACTERISTICS (continued)**

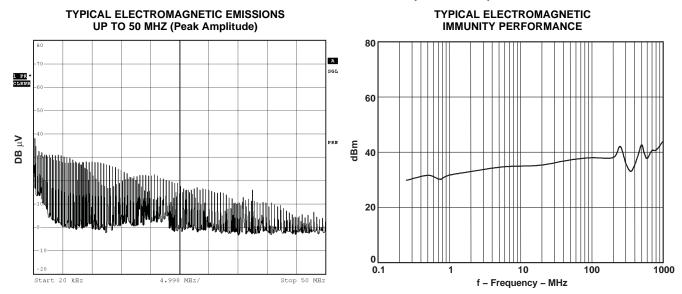


Figure 20. Frequency Spectrum of Common-Mode Emissions

Figure 21. Direct Power Injection (DPI) Response vs Frequency



#### APPLICATION INFORMATION

#### Thermal Shutdown

The SN65HVD1050 has a thermal shutdown feature that turns off the driver outputs when the junction temperature nears 190°C. This shutdown prevents catastrophic failure from bus shorts, but does not protect the circuit from possible damage. The user should strive to maintain recommended operating conditions and not exceed absolute-maximum ratings at all times. If an SN65HVD1050 is subjected to many, or long-duration faults that can put the device into thermal shutdown, it should be replaced.

#### **Bus Loading**

Q: How many HVD1050 nodes can be connected on a bus?

**A:** In the CAN standard ISO 11898-2 the driver differential output is specified with a  $60\Omega$  load (must be greater than 1.5V) and with a fully-loaded bus (must be greater than 1.2V). The HVD1050 is specified to meet the 1.5V requirement with a  $60\Omega$  load, and 1.4V with a  $45\Omega$  load. The differential input resistance of the HVD1050 is a minimum of  $30k\Omega$ . If 167 transceivers are in parallel on a bus, this is equivalent to a  $180\Omega$  differential load. That transceiver load of  $180\Omega$  in parallel with the  $60\Omega$  (two  $120\Omega$  termination resistors) gives a total  $45\Omega$ . Therefore, the HVD1050 supports over 167 transceivers on a single bus segment, with margin to the 1.2V CAN requirement.

#### **Dominant Time-Out Feature**

A dominant-time-out circuit in the SN65HVD1050 prevents the driver from blocking network communication in the event of a hardware or software failure of the local CAN controller. The time-out circuit is triggered by a falling edge on TXD (pin 1). If no rising edge is seen before the time-out constant of the circuit expires, the driver is disabled. The circuit is then reset by the next rising edge on TXD. This feature prevents a faulty local CAN controller from corrupting the entire network with a "stuck" dominant state. The dominant time-out timer is selected to pass all normal CAN messages; however, non-standard applications may inadvertently trigger the dominant time-out if long strings of dominant bits are attempted at slow data rates.

Submit Documentation Feedback



# **REVISION HISTORY**

CI	nanges from Revision A (May 2007) to Revision B	Page
•	Deleted sentence, "The device is also qualified for use in ISO 11898-2 automotive applications in accordance with AEC-Q100." and footnote, "The device is available with Q100 qualification as the SN65HVD1050Q."	1
•	Changed V <sub>CC</sub> min/max range from 4.75-5.25V to 4.5-5.5V	3
•	Changed V <sub>IH</sub> max from 5.25V to 5.5V	3
•	Added rows for various parameters showing parameters with V <sub>CC</sub> ±5% and ±10%	3
•	Added Signaling Rate spec, min 20kbps	3
•	Changed V <sub>IH</sub> min from 2 to 2.1V	3
•	Changed Bus output voltage (Dominant) CANH 4.5V < V <sub>CC</sub> < 5.5V from 4.75 to 5.2	4
•	Added Bus Loading application discussion.	16
•	Added Dominant Time-Out Feature discussion.	16

#### PACKAGE OPTION ADDENDUM

www.ti.com 2-Dec-2009

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN65HVD1050D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65HVD1050DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65HVD1050DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN65HVD1050DRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN65HVD1050:

• Automotive: SN65HVD1050-Q1

Enhanced Product: SN65HVD1050-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

# PACKAGE MATERIALS INFORMATION

www.ti.com 10-Oct-2012

# TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65HVD1050DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

**PACKAGE MATERIALS INFORMATION** 

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#### \*All dimensions are nominal

ĺ	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
	SN65HVD1050DR	SOIC	D	8	2500	367.0	367.0	35.0	

# D (R-PDSO-G8)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



# D (R-PDSO-G8)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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